

Notice of References Cited		Application/Control No. 10/523,612	Applicant(s)/Patent Under Reexamination YOSHIDA ET AL.	
		Examiner TAN X. DINH	Art Unit 2627	Page 1 of 1

U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-5,313,443 A	05-1994	Iitsuka, Hiroyuki	369/47.24
*	B	US-6,567,350 B1	05-2003	Takagi et al.	369/30.23
*	C	US-6,839,504 B1	01-2005	Gotoh et al.	386/111
*	D	US-6,947,354 B2	09-2005	Yada et al.	369/30.23
*	E	US-7,154,834 B2	12-2006	Fontijn et al.	369/59.25
*	F	US-7,366,066 B2	04-2008	Nakamura et al.	369/47.14
	G	US-			
	H	US-			
	I	US-			
	J	US-			
	K	US-			
	L	US-			
	M	US-			

FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	O					
	P					
	Q					
	R					
	S					
	T					

NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)			
	U				
	V				
	W				
	X				

*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)
Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.